

N-Channel Enhancement Mode Power MOSFET

General Description

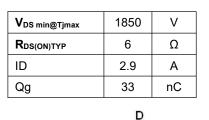
The series of Power MOSFETs use advanced technology and design. This high voltage MOSFET fits Switched applications.

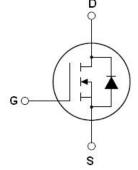
Features

- High speed switching
- Intrinsic capacitances and Qg minimized
- ●100% Avalanche Tested

Application

• Switched applications





Schematic diagram

Package Marking And Ordering Information

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Device	Device Package	Marking
NCE3N170PF	TO-3PF	NCE3N170PF



TO-3PF

Table 1. Absolute Maximum Ratings (Tc=25℃)

Parameter	Symbol	NCE3N170PF	Unit
Drain-Source Voltage (VGS=0V)	Vds	1700	V
Gate-Source Voltage (VDS=0V) DC	Vgs	±30	V
Continuous Drain Current at Tc=25°C	I _{D (DC)}	2.9	А
Continuous Drain Current at Tc=100°C	I _{D (DC)}	2.03	А
Pulsed drain current (Note 1)	I _{DM (pluse)}	8.7	А
Maximum Power Dissipation(Tc=25°C)	PD	88	W
Derate above 25°C		0.58	W/°C
Single pulse avalanche energy (Note 2)	Eas	210	mJ
Single pulse avalanche current (Note 2)	I _{AS}	2.9	А
Operating Junction and Storage Temperature Range	T _J ,T _{STG}	-55+175	°C

* limited by maximum junction temperature



Table 2. Thermal Characteristic

Parameter	Symbol	NCE3N170	Unit
Thermal Resistance, Junction-to-Case (Maximum)	R _{thJC}	1.7	°C /W
Thermal Resistance, Junction-to-Ambient (Maximum)	R _{thJA}	50	°C /W

Table 3. Electrical Characteristics (TA=25°C unless otherwise noted)

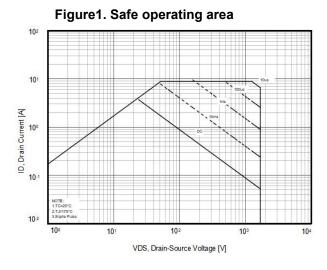
Parameter	Symbol	Condition	Min	Тур	Max	Unit
On/off states						
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V I _D =1mA 1700				V
Zero Gate Voltage Drain Current(Tc=25°C)	I _{DSS}	V _{DS} =1700V,V _{GS} =0V			1	μA
Zero Gate Voltage Drain Current(Tc=125°C)	IDSS	V _{DS} =1700V,V _{GS} =0V			100	μA
Gate-Body Leakage Current	Igss	V _{GS} =±30V,V _{DS} =0V			±100	nA
Gate Threshold Voltage	V _{GS(th)}	V _{DS} =V _{GS} ,I _D =250µA	3	4	5	V
Drain-Source On-State Resistance	R _{DS(ON)}	V _{GS} =10V, I _D =1.45A		6	8	Ω
Dynamic Characteristics						
Input Capacitance	Clss			1700		pF
Output Capacitance	Coss	V _{DS} =40V,V _{GS} =0V, F=1.0MHz		60		pF
Reverse Transfer Capacitance	C _{rss}			3.3		pF
Total Gate Charge	Qg			33		nC
Gate-Source Charge	Q _{gs}	V _{DS} =1350V,I _D =1.45A, V _{GS} =10V		7.7		nC
Gate-Drain Charge	Q _{gd}	VGS-10V		14		nC
Intrinsic gate resistance	R _G	f = 1 MHz open drain		2		Ω
Switching times					•	
Turn-on Delay Time	t _{d(on)}			22		nS
Turn-on Rise Time	tr	V _{DD} =850V,I _D =1.45A,		8		nS
Turn-Off Delay Time	t _{d(off)}	$R_G=3\Omega, V_{GS}=10V$		48		nS
Turn-Off Fall Time	t _f			49		nS
Source- Drain Diode Characteristics						
Source-drain current(Body Diode)	Isd	T _c =25°C			2.9	А
Pulsed Source-drain current(Body Diode)	Isdm	1 _C -25 C			8.7	А
Forward On Voltage	Vsd	Tj=25°C,I _{SD} =2.9A,V _{GS} =0V		0.8	1.1	V
Reverse Recovery Time	t _{rr}	— Tj=25°C,I⊧=2.9A, — di/dt=100A/μs		1500		nS
Reverse Recovery Charge	Qrr			5.7		uC
Peak Reverse Recovery Current	Irrm			7.5		А

Notes 1.Repetitive Rating: Pulse width limited by maximum junction temperature

2. Tj=25°C,VDD=50V,VG=10V, R_G=25 Ω



TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS (curves)





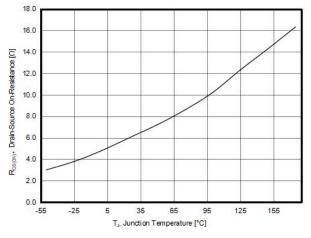


Figure 5. Maximum I_D vs Junction Temperature

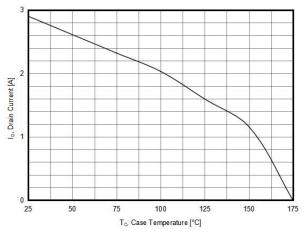


Figure2. Source-Drain Diode Forward Voltage

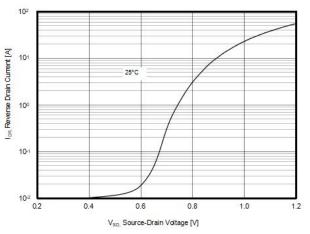


Figure4. BV_{DSS} vs Junction Temperature

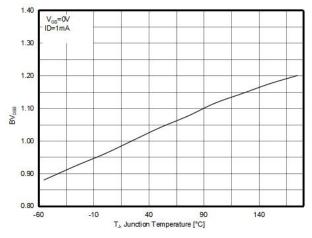


Figure6. Output characteristics

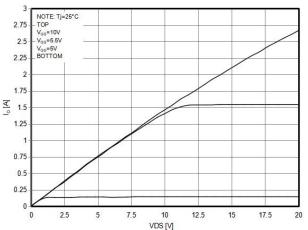
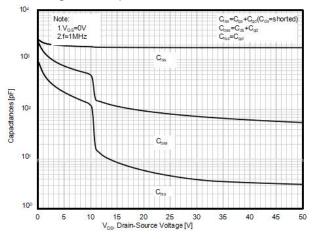
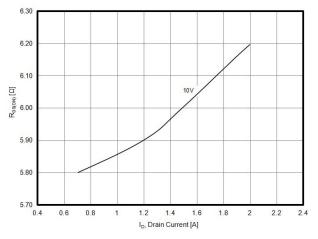




Figure7. Capacitance



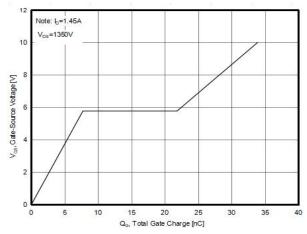




3.5 3 2.5 Io, Drain Current[A] 2 25°C 1.5 Notes: - 1. V_{DS}=-30V 2. 250us Pulse Test 0.5 0 2 3 4 5 6 7 8 V_{GS}, Gate-Source Voltage[V]

Figure8. Transfer characteristics

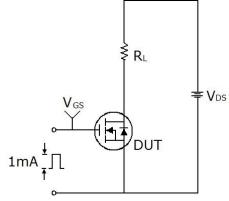


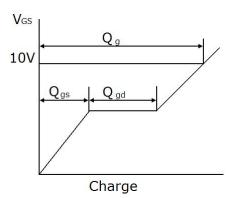




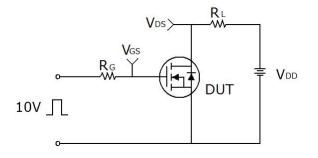
Test circuit

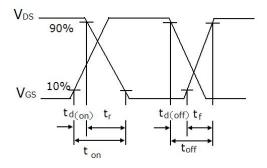
1) Gate charge test circuit & Waveform



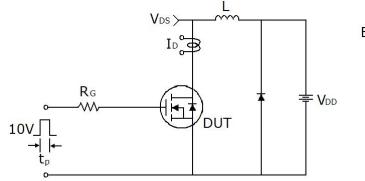


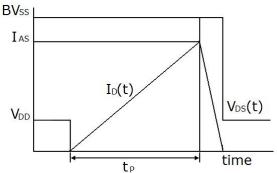
2) Switch Time Test Circuit:





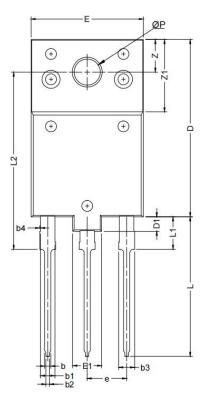
3) Unclamped Inductive Switching Test Circuit & Waveforms

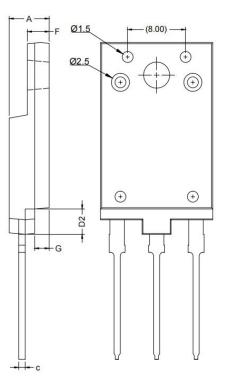






TO-3PF-B Package Information





Symbol	Dimensions	In Millimeters	Dimensions In Inches		
Symbol	Min.	Max.	Min.	Max.	
A	5.300	5.700	0.209	0.224	
b	0.650	0.950	0.026	0.037	
b4		0.200		0.008	
С	0.800	1.000	0.031	0.039	
D	24.200	24.800	0.953	0.976	
D1	1.800	2.200	0.071	0.087	
D2	3.300	3.700	0.130	0.146	
E	15.300	15.700	0.602	0.618	
E1	3.800	4.200	0.150	0.165	
F	2.800	3.200	0.110	0.126	
е	5.450	5.450 BSC		5 BSC	
L	19.000	19.600	0.748	0.772	
L1	4.200	4.800	0.165	0.189	
L2	24.200	24.800	0.953	0.976	
Р	3.400	3.800	0.134	0.150	
Z	4.300	4.700	0.169	0.185	
Z1	9.700	10.300	0.382	0.406	
G	1.800	2.200	0.071	0.087	
S	3.100	3.500	0.122	0.138	



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